

IHM-B module with fast Trench/Fieldstop IGBT4 and Emitter Controlled diode and pre-applied Thermal Interface Material

Typical Applications

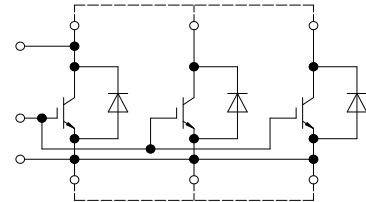
- High power converters
- Motor drives

Electrical Features

- Extended operating temperature $T_{vj\,op}$
- Low switching losses
- Low V_{CESat}
- $T_{vj\,op} = 150^{\circ}\text{C}$

Mechanical Features

- 4 kV AC 1min insulation
- Package with CTI > 400
- High creepage and clearance distances
- High power density
- IHM B housing
- Copper base plate
- RoHS compliant
- Pre-applied Thermal Interface Material



external connection
(to be done)

$$V_{CES} = 1700\text{V}$$

$$I_{C\,nom} = 2400\text{A} / I_{CRM} = 4800\text{A}$$

IGBT, Inverter

Maximum Rated Values

Collector-emitter voltage	$T_{vj} = 25^{\circ}\text{C}$	V_{CES}	1700	V
Continuous DC collector current	$T_H = 80^{\circ}\text{C}, T_{vj\,max} = 175^{\circ}\text{C}$	$I_{C\,nom}$	2400	A
Repetitive peak collector current	$t_p = 1\text{ ms}$	I_{CRM}	4800	A
Gate-emitter peak voltage		V_{GES}	+/-20	V

Diode, Inverter

Maximum Rated Values

Repetitive peak reverse voltage	$T_{vj} = 25^{\circ}\text{C}$	V_{RRM}	1700	V
Continuous DC forward current		I_F	2400	A
Repetitive peak forward current	$t_p = 1\text{ ms}$	I_{FRM}	4800	A
I^2t -value	$V_R = 0\text{ V}, t_p = 10\text{ ms}, T_{vj} = 125^{\circ}\text{C}$	I^2t	1000	kA^2s
	$V_R = 0\text{ V}, t_p = 10\text{ ms}, T_{vj} = 150^{\circ}\text{C}$		940	kA^2s

Characteristic Values

Parameter	Test Conditions		Symbol	min.	typ.	max.	Unit
Collector-emitter saturation voltage	$I_c = 2400 \text{ A}, V_{GE} = 15 \text{ V}$	$T_{vj} = 25^\circ\text{C}$	$V_{CE \text{ sat}}$		1.95	2.3	V
	$I_c = 2400 \text{ A}, V_{GE} = 15 \text{ V}$	$T_{vj} = 125^\circ\text{C}$			2.35	2.75	V
	$I_c = 2400 \text{ A}, V_{GE} = 15 \text{ V}$	$T_{vj} = 150^\circ\text{C}$			2.45	2.9	V
Gate threshold voltage	$I_c = 96,0 \text{ mA}, V_{CE} = V_{GE}, T_{vj} = 25^\circ\text{C}$		$V_{GE(th)}$	5.20	5.8	6.4	V
Gate charge	$V_{GE} = -15 \text{ V} \dots +15 \text{ V}$		Q_G		25		μC
Internal gate resistor	$T_{vj} = 25^\circ\text{C}$		R_{Gint}		0.65		Ω
Input capacitance	$f = 1 \text{ MHz}, T_{vj} = 25^\circ\text{C}, V_{CE} = 25 \text{ V}, V_{GE} = 0 \text{ V}$		C_{ies}		195		nF
Reverse transfer capacitance	$f = 1 \text{ MHz}, T_{vj} = 25^\circ\text{C}, V_{CE} = 25 \text{ V}, V_{GE} = 0 \text{ V}$		C_{res}		6.3		nF
Collector-emitter cut-off current	$V_{CE} = 1700 \text{ V}, V_{GE} = 0 \text{ V}, T_{vj} = 25^\circ\text{C}$		I_{CES}			5.0	mA
Gate-emitter leakage current	$V_{CE} = 0 \text{ V}, V_{GE} = 20 \text{ V}, T_{vj} = 25^\circ\text{C}$		I_{GES}			400	nA
Turn-on delay time, inductive load	$I_c = 2400 \text{ A}, V_{CE} = 900 \text{ V}$	$T_{vj} = 25^\circ\text{C}$	t_{don}		0.46		μs
	$V_{GE} = \pm 15 \text{ V}$	$T_{vj} = 125^\circ\text{C}$			0.5		μs
	$R_{Gon} = 0,8 \Omega$	$T_{vj} = 150^\circ\text{C}$			0.53		μs
Rise time, inductive load	$I_c = 2400 \text{ A}, V_{CE} = 900 \text{ V}$	$T_{vj} = 25^\circ\text{C}$	t_r		0.21		μs
	$V_{GE} = \pm 15 \text{ V}$	$T_{vj} = 125^\circ\text{C}$			0.22		μs
	$R_{Gon} = 0,8 \Omega$	$T_{vj} = 150^\circ\text{C}$			0.23		μs
Turn-off delay time, inductive load	$I_c = 2400 \text{ A}, V_{CE} = 900 \text{ V}$	$T_{vj} = 25^\circ\text{C}$	t_{doff}		1.40		μs
	$V_{GE} = \pm 15 \text{ V}$	$T_{vj} = 125^\circ\text{C}$			1.55		μs
	$R_{Goff} = 0,8 \Omega$	$T_{vj} = 150^\circ\text{C}$			1.60		μs
Fall time, inductive load	$I_c = 2400 \text{ A}, V_{CE} = 900 \text{ V}$	$T_{vj} = 25^\circ\text{C}$	t_f		0.16		μs
	$V_{GE} = \pm 15 \text{ V}$	$T_{vj} = 125^\circ\text{C}$			0.41		μs
	$R_{Goff} = 0,8 \Omega$	$T_{vj} = 150^\circ\text{C}$			0.50		μs
Turn-on energy loss per pulse	$I_c = 2400 \text{ A}, V_{CE} = 900 \text{ V}, L_s = 50 \text{ nH}$	$T_{vj} = 25^\circ\text{C}$	E_{on}		510		mJ
	$V_{GE} = \pm 15 \text{ V}, di/dt = 11500 \text{ A}/\mu\text{s}$ ($T_{vj} = 150^\circ\text{C}$)	$T_{vj} = 125^\circ\text{C}$			620		mJ
	$R_{Gon} = 0,8 \Omega$	$T_{vj} = 150^\circ\text{C}$			650		mJ

Turn-off energy loss per pulse	$I_c = 2400\text{ A}, V_{CE} = 900\text{ V}, L_S = 50\text{ nH}$	$T_{vj} = 25^\circ\text{C}$	E_{off}		630		mJ
	$V_{GE} = \pm 15\text{ V}, du/dt = 2500\text{ V}/\mu\text{s}$ ($T_{vj} = 150^\circ\text{C}$)	$T_{vj} = 125^\circ\text{C}$			920		mJ
	$R_{Goff} = 0,8\ \Omega$	$T_{vj} = 150^\circ\text{C}$			1000		mJ
SC data	$V_{GE} \leq 15\text{ V}, V_{CC} = 1000\text{ V}$	$t_p \leq 10\ \mu\text{s}, T_{vj} = 150^\circ\text{C}$	I_{sc}		11000		A
	$V_{CEmax} = V_{CES} - L_{SCE} \cdot di/dt$						
Thermal resistance, junction to heatsink	pro IGBT / per IGBT		R_{thJH}			13.1	K/kW
	valid with IFX pre-applied thermal interface material						
Temperature under switching conditions			$T_{vj\ op}$	-40		150	$^\circ\text{C}$

Characteristic Values

Parameter	Test Conditions		Symbol	min.	typ.	max.	Unit
Forward voltage	$I_F = 2400\text{ A}, V_{GE} = 0\text{ V}$	$T_{vj} = 25^\circ\text{C}$	V_F		1.80	2.20	V
	$I_F = 2400\text{ A}, V_{GE} = 0\text{ V}$	$T_{vj} = 125^\circ\text{C}$			1.90	2.30	V
	$I_F = 2400\text{ A}, V_{GE} = 0\text{ V}$	$T_{vj} = 150^\circ\text{C}$			1.95	2.40	V
Peak reverse recovery current	$I_F = 2400\text{ A}, -di_F/dt = 11500\text{ A}/\mu\text{s}$ ($T_{vj}=150^\circ\text{C}$)	$T_{vj} = 25^\circ\text{C}$	I_{RM}		1950		A
	$V_R = 900\text{ V}$	$T_{vj} = 125^\circ\text{C}$			2450		A
	$V_{GE} = -15\text{ V}$	$T_{vj} = 150^\circ\text{C}$			2600		A
Recovered charge	$I_F = 2400\text{ A}, -di_F/dt = 11500\text{ A}/\mu\text{s}$ ($T_{vj}=150^\circ\text{C}$)	$T_{vj} = 25^\circ\text{C}$	Q_r		530		μC
	$V_R = 900\text{ V}$	$T_{vj} = 125^\circ\text{C}$			960		μC
	$V_{GE} = -15\text{ V}$	$T_{vj} = 150^\circ\text{C}$			1100		μC
Reverse recovery energy	$I_F = 2400\text{ A}, -di_F/dt = 11500\text{ A}/\mu\text{s}$ ($T_{vj}=150^\circ\text{C}$)	$T_{vj} = 25^\circ\text{C}$	E_{rec}		330		mJ
	$V_R = 900\text{ V}$	$T_{vj} = 125^\circ\text{C}$			660		mJ
	$V_{GE} = -15\text{ V}$	$T_{vj} = 150^\circ\text{C}$			790		mJ
Thermal resistance, junction to heatsink	per diode		R_{thJH}			20.2	K/kW
	valid with IFX pre-applied thermal interface material						
Temperature under switching conditions			$T_{vj\ op}$	-40		150	$^\circ\text{C}$

Module

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Isolation test voltage	RMS, f = 50 Hz, t = 1 min.	V_{ISOL}	4.0	kV
Material of module baseplate			Cu	
Internal isolation	basic insulation (class 1, IEC 61140)		Al ₂ O ₃	
Creepage distance	terminal to heatsink		32.2	mm
	terminal to terminal		32.2	mm
Clearance	terminal to heatsink		19.1	mm
	terminal to terminal		19.1	mm
Comparative tracking index		CTI	> 400	

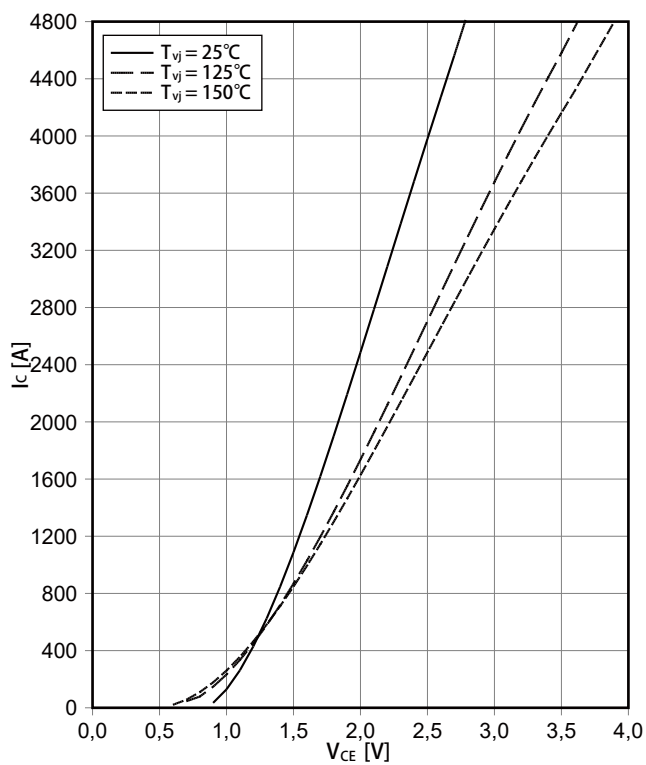
Parameter	Test Conditions	Symbol	min.	typ.	max.	Unit
Stray inductance module		L_{SCE}		6.0		nH
Module lead resistance, terminals-chip	$T_H = 25^\circ\text{C}$, per switch	$R_{CC'+EE'}$		0.10		mΩ
Storage temperature		T_{stg}	-40		125	°C
Maximum baseplate operation temperature		T_{BPmax}			125	°C
Mounting torque for modul mounting	Screw M6 - Mounting according to valid application note	M	4.25		5.75	Nm
Terminal connection torque	Screw M4 - Mounting according to valid application note	M	1.8	-	2.1	Nm
	Screw M8 - Mounting according to valid application note		8.0	-	10	Nm
Weight		G		1900		g

Storage and shipment of modules with TIM according to AN2012-07

output characteristic IGBT, Inverter (typical)

$$I_C = f(V_{CE})$$

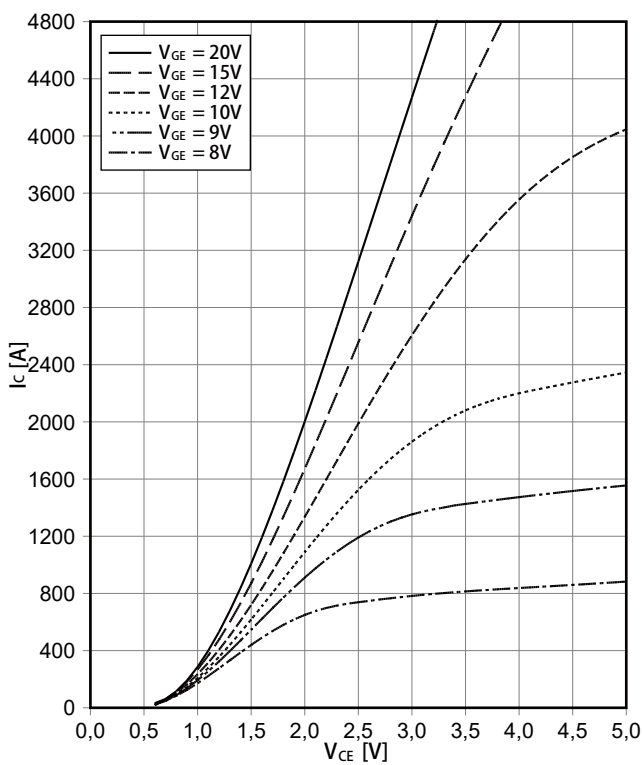
$$V_{GE} = 15 \text{ V}$$



output characteristic IGBT, Inverter (typical)

$$I_C = f(V_{CE})$$

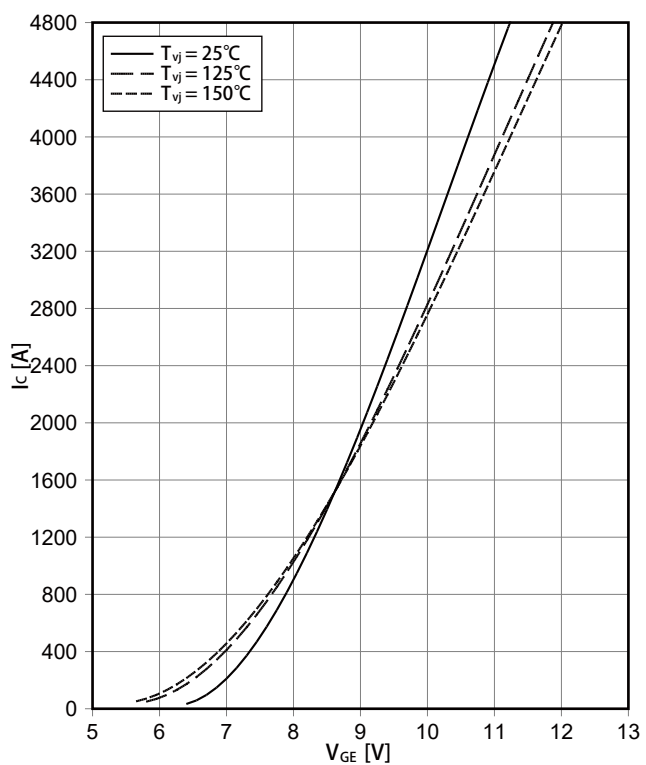
$$T_{vj} = 150^\circ\text{C}$$



transfer characteristic IGBT, Inverter (typical)

$$I_C = f(V_{GE})$$

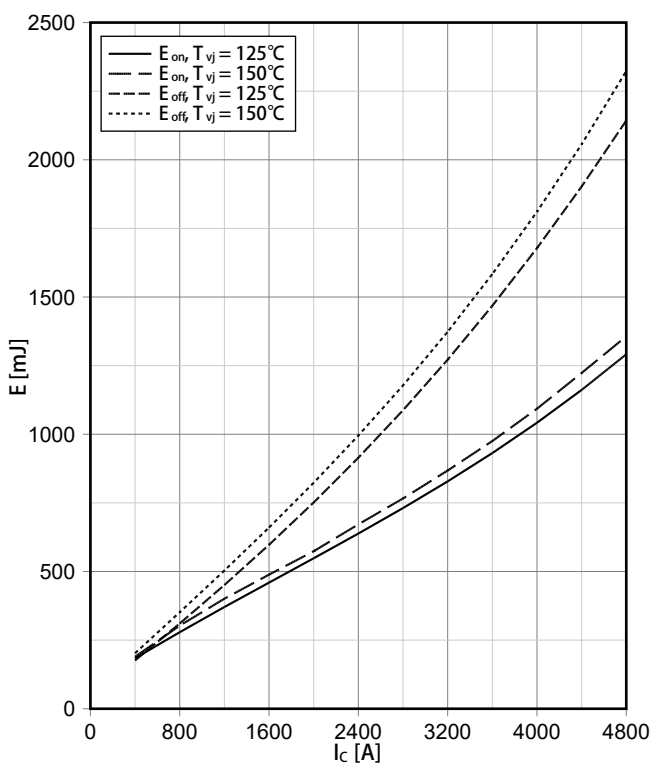
$$V_{CE} = 20 \text{ V}$$



switching losses IGBT, Inverter (typical)

$$E_{on} = f(I_C), E_{off} = f(I_C)$$

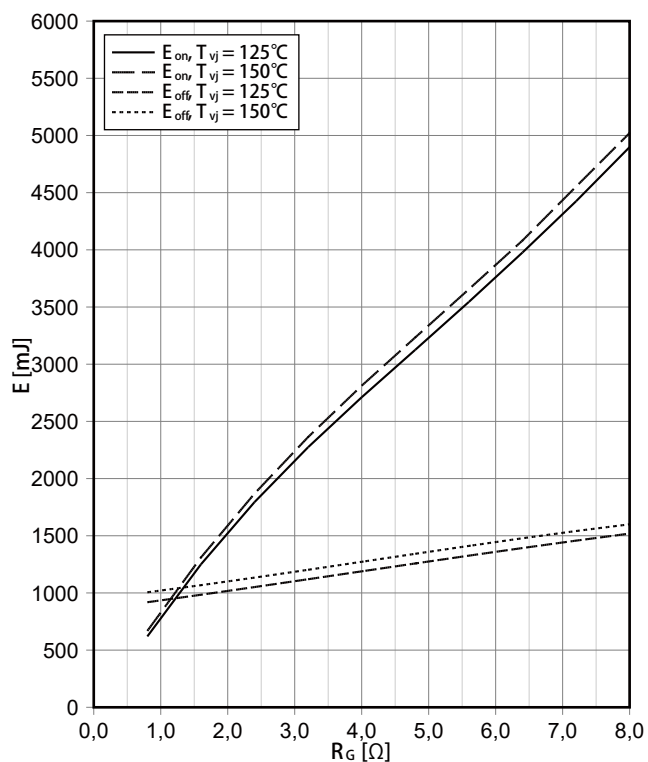
$$V_{GE} = \pm 15 \text{ V}, R_{Gon} = 0.8 \Omega, R_{Goff} = 0.8 \Omega, V_{CE} = 900 \text{ V}$$



switching losses IGBT, Inverter (typical)

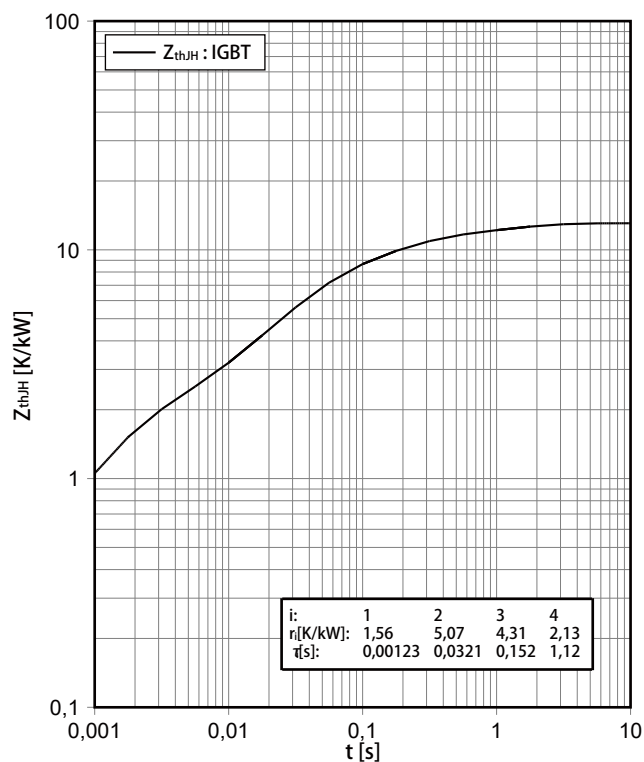
$$E_{on} = f(R_G), E_{off} = f(R_G)$$

$$V_{GE} = \pm 15 \text{ V}, I_C = 2400 \text{ A}, V_{CE} = 900 \text{ V}$$



transient thermal impedance IGBT, Inverter

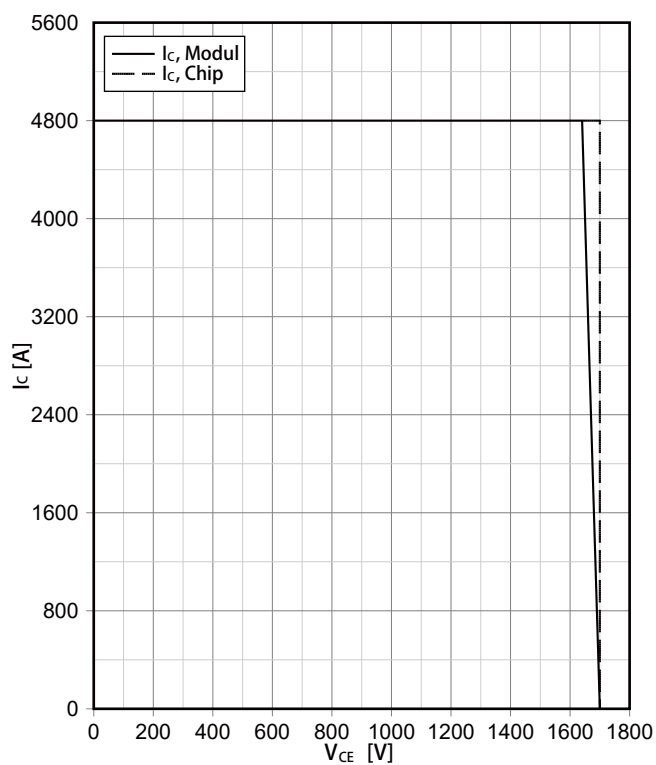
$$Z_{thJH} = f(t)$$



reverse bias safe operating area IGBT, Inverter (RBSOA)

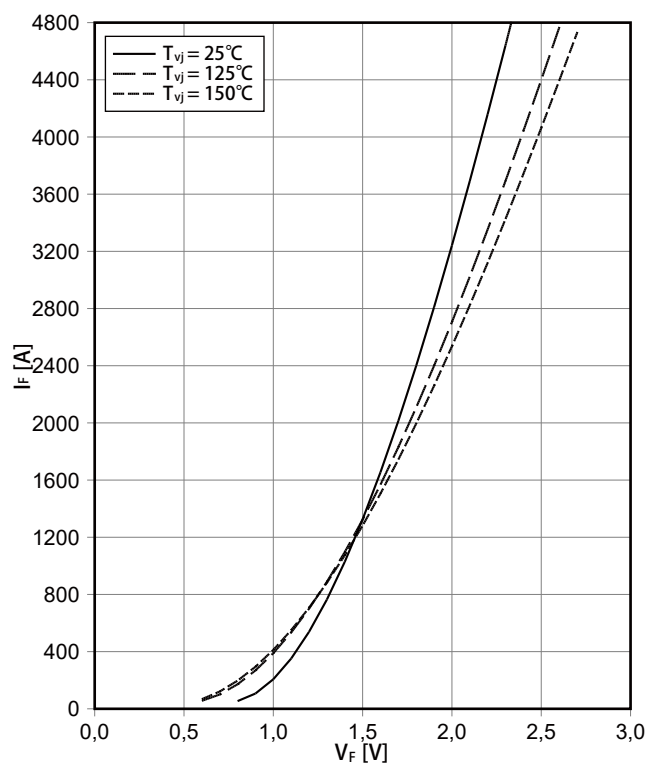
$$I_C = f(V_{CE})$$

$$V_{GE} = \pm 15 \text{ V}, R_{Goff} = 0.8 \Omega, T = 150^\circ\text{C}$$



forward characteristic of Diode, Inverter (typical)

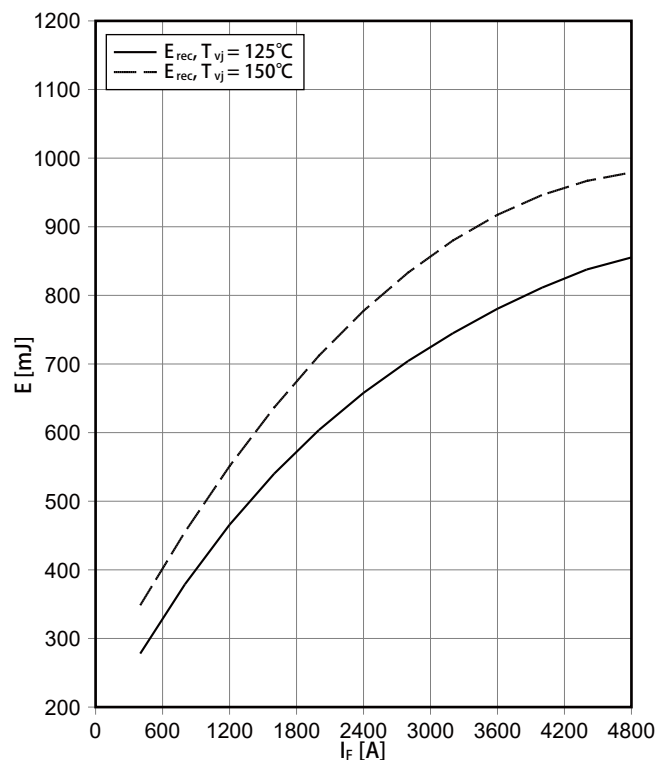
$$I_F = f(V_F)$$



switching losses Diode, Inverter (typical)

$$E_{\text{rec}} = f(I_F)$$

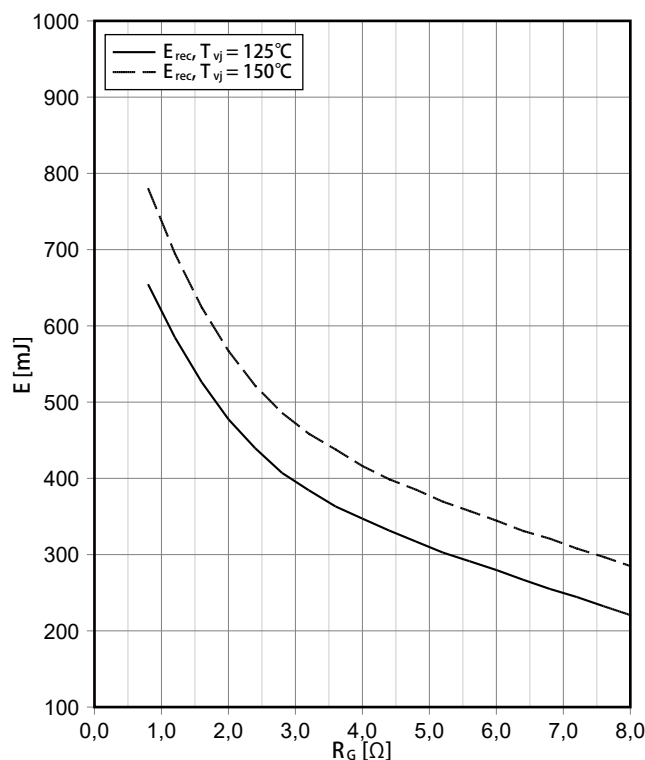
$$R_{\text{Gon}} = 0.8 \, \Omega, V_{\text{CE}} = 900 \, \text{V}$$



switching losses Diode, Inverter (typical)

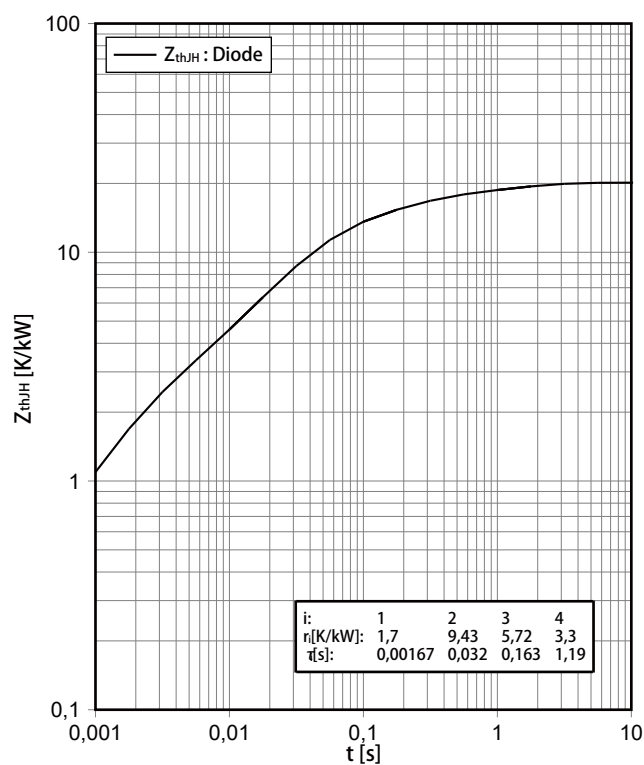
$$E_{\text{rec}} = f(R_G)$$

$$I_F = 2400 \, \text{A}, V_{\text{CE}} = 900 \, \text{V}$$

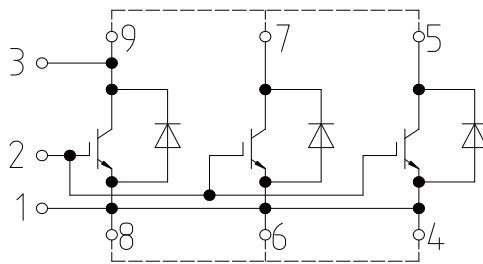


transient thermal impedance Diode, Inverter

$$Z_{\text{thJH}} = f(t)$$



Circuit diagram



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external connection
(to be done)
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Package outlines

